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REFERENCE

DEVICE SPECIFICATION FOR
PHOTOCOUPLER
MODEL No. PC815

Business dealing name

	PC815XNNSZ0F		PC815XNYSZ0F
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Specified for _____

Enclosed please find copies of the Specifications which consists of 15 pages including cover.
This specification sheets and attached sheets shall be both side copy.
After confirmation of the contents, please be sure to send back copies of the Specifications
with approving signature on each.

CUSTOMER'S APPROVAL

DATE _____

BY _____

PRESENTED

DATE July 21, 2009

BY M. Kubo
for

M. Kubo,
Department General Manager of
Development Dept. IV
System Device Div. I
Electronic Components and Devices Group
SHARP CORPORATION

REFERENCE

Business dealing name

PC815XNNSZ0F	PC815XNYSZ0F
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1. These specification sheets include materials protected under copyright of Sharp Corporation ("Sharp"). Please do not reproduce or cause anyone to reproduce them without Sharp's consent.
2. When using this product, please observe the absolute maximum ratings and the instructions for use outlined in these specification sheets, as well as the precautions mentioned below. Sharp assumes no responsibility for any damage resulting from use of the product which does not comply with the absolute maximum ratings and the instructions included in these specification sheets, and the precautions mentioned below.

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6.8 Compliance with each regulation

(1) The RoHS directive (2002/95/EC)

This product complies with the RoHS directive (2002/95/EC).

Object substances: mercury, lead, cadmium, hexavalent chromium, polybrominated biphenyls (PBB) and polybrominated diphenyl ethers (PBDE)

(2) Content of six substances specified in Management Methods for Control of Pollution Caused by Electronic Information Products Regulation (Chinese : 电子信息产品污染控制管理办法).

Category	Toxic and hazardous substances					
	Lead (Pb)	Mercury (Hg)	Cadmium (Cd)	Hexavalent chromium (Cr ⁶⁺)	Polybrominated biphenyls (PBB)	Polybrominated diphenyl ethers (PBDE)
Photocoupler	✓	✓	✓	✓	✓	✓

✓: indicates that the content of the toxic and hazardous substance in all the homogeneous materials of the part is below the concentration limit requirement as described in SJ/T 11363-2006 standard.

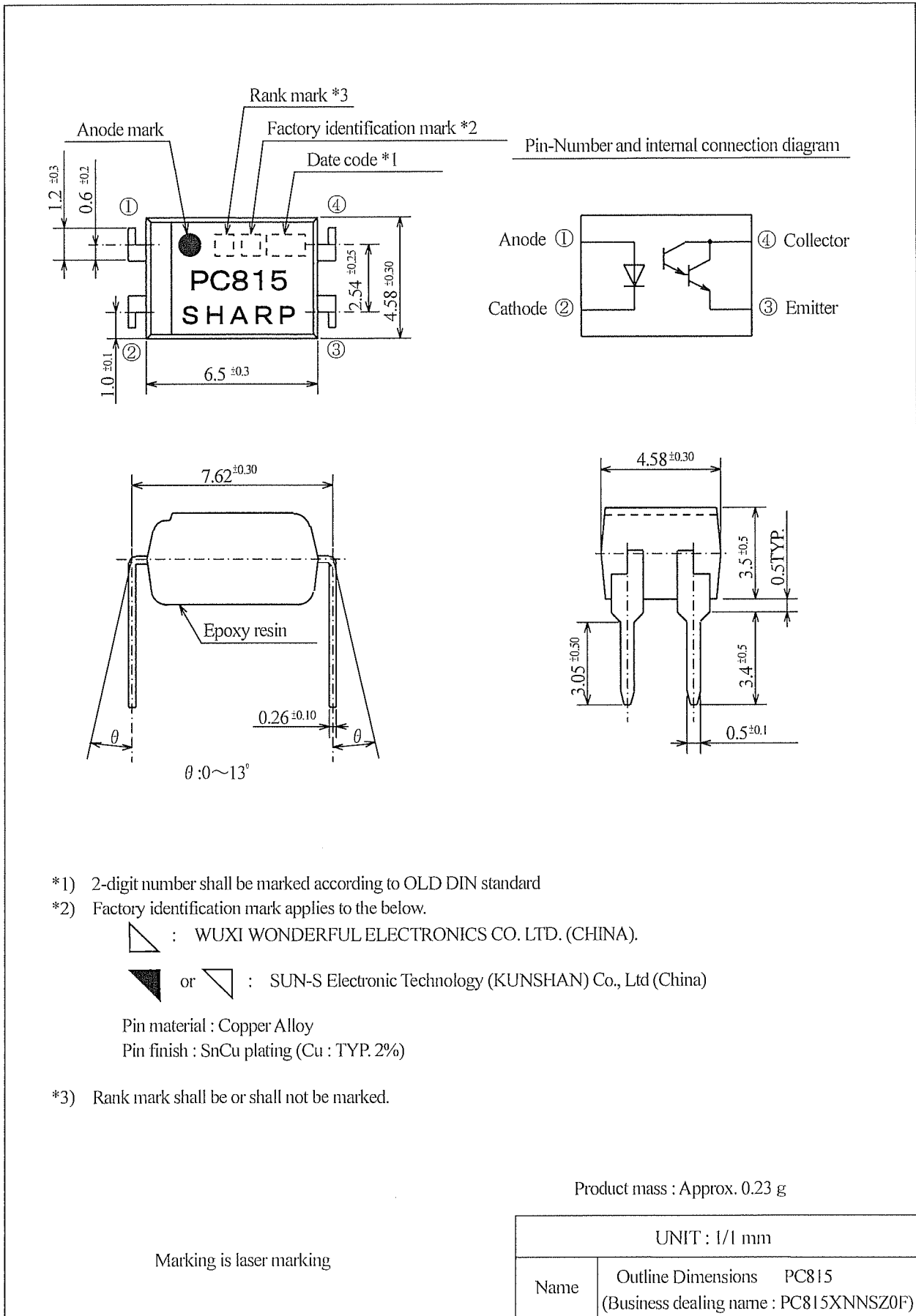
7. Notes

Precautions for photocouplers : Attachment-1

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2. Outline



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3. Ratings and characteristics

3.1 Absolute maximum ratings

Ta=25°C

	Parameter	Symbol	Rating	Unit
Input	*1 Forward current	I_F	50	mA
	*2 Peak forward current	I_{FM}	1	A

	Parameter	Symbol	Condition	MIN.	TYP.	MAX.	Unit
Input	Forward voltage	V_F	$I_F=20mA$	-	1.2	1.4	V
	Peak forward voltage	V_{FM}	$I_{FM}=0.5A$	-	-	3.0	V
	Reverse current	I_R	$V_R=4V$	-	-	10	μA
	Terminal capacitance	C_t	$V=0, f=1kHz$	-	30	250	pF
Output	Dark current	I_{CEO}	$V_{CE}=10V, I_F=0$	-	-	1000	nA
	Collector-emitter breakdown voltage	BV_{CEO}	$I_c=0.1mA, I_F=0$	35	-	-	V
	Emitter-collector breakdown voltage	BV_{ECO}	$I_E=10 \mu A, I_F=0$	6	-	-	V
Transfer characteristics	Collector current	I_c	$I_F=1mA, V_{CE}=2V$	6	16	75	mA
	Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_F=20mA, I_c=5mA$	-	0.8	1.0	V
	Isolation resistance	R_{ISO}	DC500V 40 to 60%RH	5×10^{10}	10^{11}	-	Ω
	Floating capacitance	C_f	$V=0, f=1MHz$	-	0.6	1.0	pF
	Cut-off frequency	f_c	$V_{CE}=2V, I_c=2mA$ $R_L=100 \Omega, -3dB$	1	6	-	kHz
	Rise time	t_r	$V_{CE}=2V, I_c=10mA$	-	60	300	μs
Fall time	t_f	$R_L=100 \Omega$	-	53	250	μs	

*1 The derating factors of absolute maximum ratings due to ambient temperature are shown in Fig. 1 to 4.

*2 Pulse width $\leq 100 \mu s$, Duty ratio : 0.001 (Refer to Fig. 5)

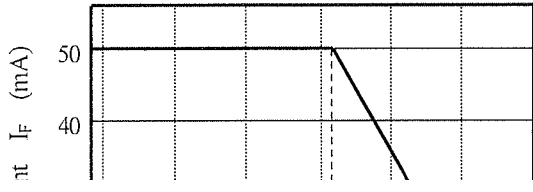
*3 AC for 1 min, 40 to 60%RH

*4 For 10 s

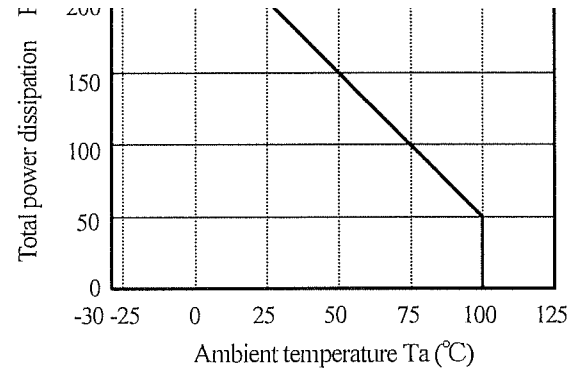
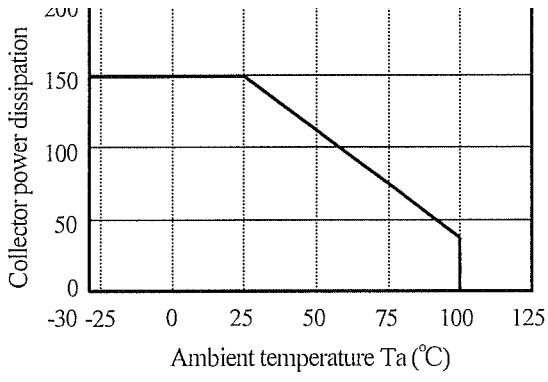
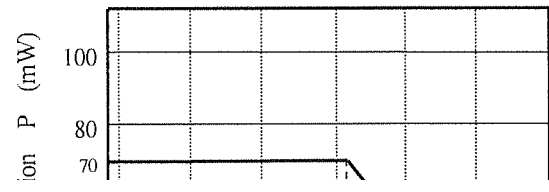
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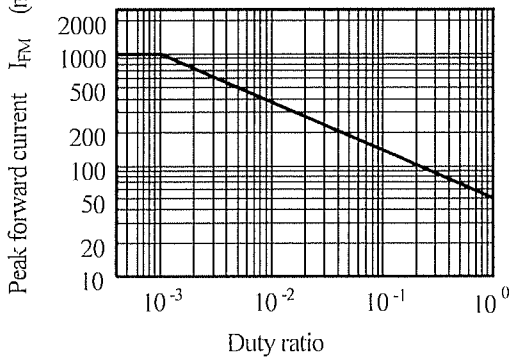
(Fig.1) Forward current vs. ambient temperature



(Fig.2) Diode power dissipation vs. ambient temperature



(Fig.5) Forward current vs. duty ratio
Pulse width $\leq 100 \mu s$
 $T_a = 25^\circ C$



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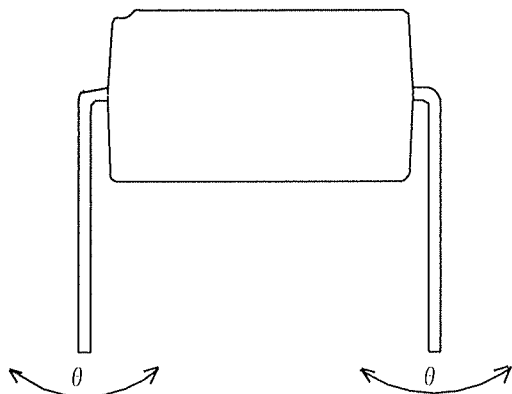
4. Reliability

The reliability of products shall satisfy items listed below.

Confidence level : 90%
LTPD : 10 or 20

Test Items	Condition	Failure Judgment Criteria	Samples (n) Defective (C)
Solderability	245±3°C, 5s	*2	n=11, C=0
Soldering heat	(Flow soldering) 270°C, 10 s	$V_F > U \times 1.2$ $I_R > U \times 2$ $I_{CEO} > U \times 2$ $I_C < L \times 0.7$ $V_{CE(sat)} > U \times 1.2$ U: Upper specification limit L: Lower specification limit	n=11, C=0
	(Soldering by hand) 400°C, 3 s		n=11, C=0
Terminal strength (Tension)	Weight: 5N 5 s/each terminal		n=11, C=0
Terminal strength (Bending) *3	Weight: 2.5N 2 times/each terminal		n=11, C=0
Mechanical shock	15km/s ² , 0.5ms 3 times/±X, ±Y, ±Z direction		n=11, C=0
Variable frequency vibration	100 to 2000 to 100Hz/4 min 200m/s ² 4 times/X, Y, Z direction		n=11, C=0
Temperature cycling	1 cycle -55 °C to +125 °C (30 min) (30 min) 20 cycles test		n=22, C=0
High temp. and high Humidity storage	+85°C, 85%RH, 1000h		n=22, C=0
High temp. storage	+125 °C, 1000h		n=22, C=0
Low temp. storage	-55 °C, 1000h		n=22, C=0
Operation life	I _F =50mA, P _{tot} =200mW T _a =25 °C, 1000h	n=22, C=0	

- *1 Test method, conforms to EIAJ ED 4701.
- *2 The product whose not-soldered area is more than 5% for all of the dipped area, and/or whose pinholes or voids are concentrated on one place shall be judged defect.
- *3 Terminal bending direction is shown below.



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A single sampling plan, normal inspection level II based on ISO 2859 is applied.
The AQL according to the inspection items are shown below.

Defect	Inspection item	AQL (%)
Major defect	Electrical characteristics Unreadable marking	0.065
Minor defect	Appearance defect except the above mentioned.	0.25

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6.2 Packing specification

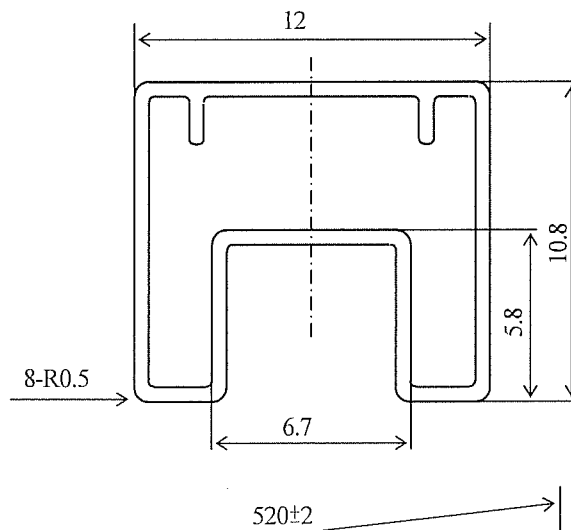
6.2.1 Package materials

No.	Name	Materials	Purposes
①	Sleeve	HIPS or ABS with preventing static electricity	Products packaged
②	Stopper	Styrene-Elastomer	Products fixed
③	Packing case	Corrugated cardboard	Sleeve packaged
④	Kraft tape	Paper	Lid of packaged case fixed
⑤	Label	Paper	Model No.,(Business dealing name),Lot No., Quantity, country of origin , Company name and inspection date specified

6.2.2 Package method

- (1) MAX. 100pcs. of products shall be packaged in a sleeve ① and both of sleeve edges shall be fixed by stoppers ②.
- (2) MAX. 20 sleeves (Product : 2000pcs.) above shall be packaged in a packing case ③.
- (3) The label ⑤ shall be put on the side of the packing case.
- (4) Case shall be closed with the lid and enclosed with kraft tape ④.

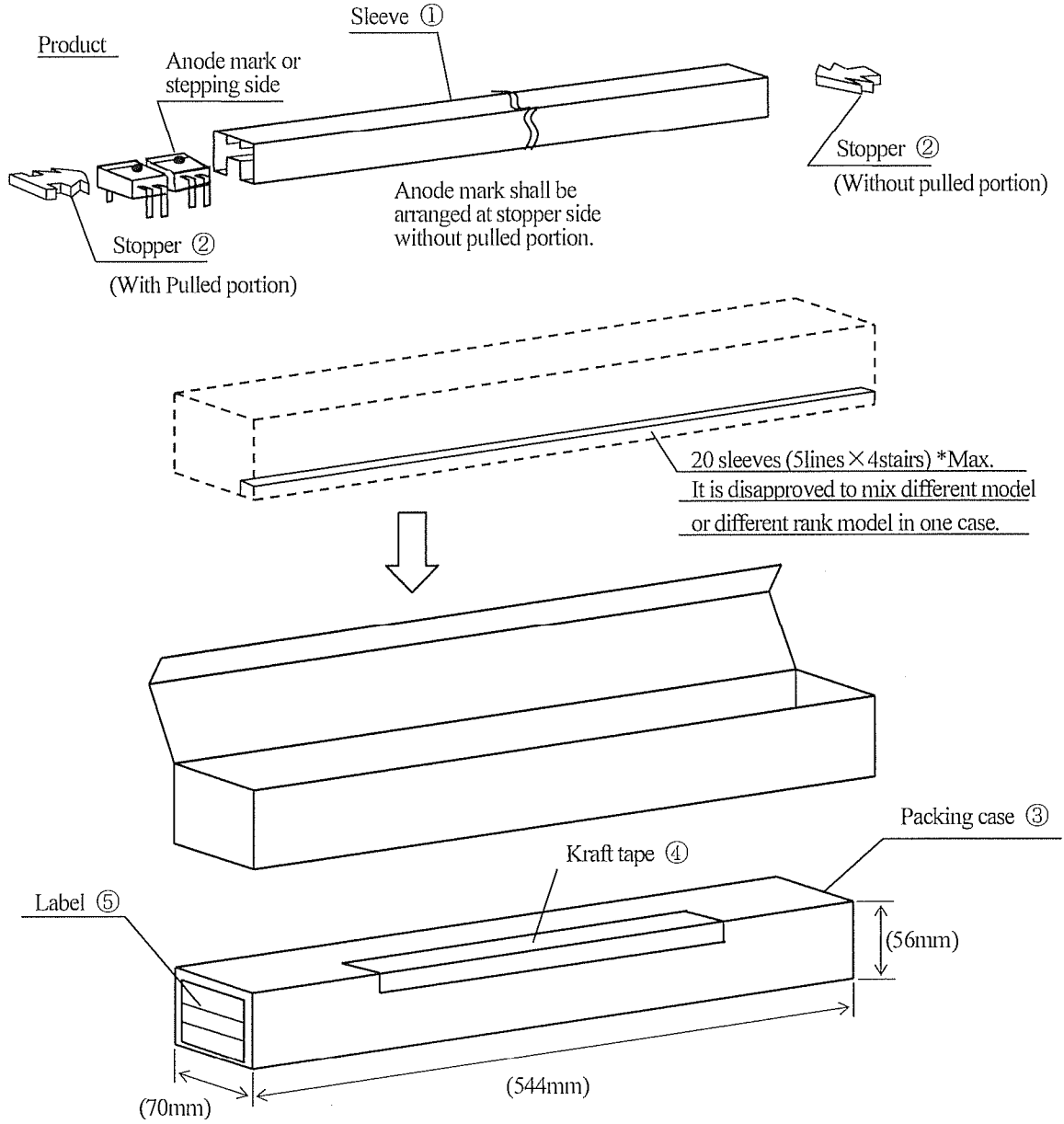
6.2.3 Sleeve package ① outline dimensions



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6.2.4 Packing outer case outline dimensions



Regular packing mass : Approx. 860g

() : Reference dimensions

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Precautions for Photocouplers

1. Cleaning

- (1) Solvent cleaning : Solvent temperature 45°C or less
Immersion for 3 min or less
- (2) Ultrasonic cleaning : The effect to device by ultrasonic cleaning differs by cleaning bath size, ultrasonic power output, cleaning time, PCB size or device mounting condition etc.

3. Precautions for Soldering


- (1) In the case of flow soldering (Whole dipping is possible)
It is recommended that flow soldering should be at 270°C or less for 10 s or less
(Pre-heating : 100 to 150°C, 30 to 80s). (2 times or less)
- (2) In the case of hand soldering
What is done on the following condition is recommended.(2 times or less)
Soldering iron temperature : 400°C or less
Time : 3s or less
- (3) Other precautions
Depending on equipment and soldering conditions (temperature, Using solder etc.),
the effect to the device and the PCB is different.
Please confirm that there is no problem on the actual use conditions in advance.

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1. This specification shall be applied to photocoupler, Model No. PC815 as an option.
2. Applicable Models (Business dealing name)
PC815XNYSZ0F
3. The relevant models are the models Approved by VDE according to DIN EN 60747-5-2.
Approved Model No. : PC815
VDE approved No. : 40008087 (According to the specification DIN EN 60747-5-2)
 - Operating isolation voltage U_{IORM} : 890V (Peak)
 - Transient voltage : 9000V (Peak)
 - Pollution : 2
 - Clearances distance (Between input and output) : 6.4 mm (MIN.)
 - Creepage distance (Between input and output) : 6.4 mm (MIN.)
 - Isolation thickness between input and output : 0.15mm (MIN.)
 - Tracking-proof : CTI 175
 - Safety limit values
 - Current (Isi) : 200mA (Diode side)
 - Power (Psi) : 260mW (Phototransistor side)
 - Temperature (Tsi) : 150°C

In order to keep safety electric isolation of photocoupler, please set the protective circuit to keep within safety limit values when the actual application equipment troubled.

- Indication of VDE approval prints "  " on minimum unit package.

4. Outline Refer to the attachment-2-2.

5. Isolation specification according to EN 60747-5-2.

Parameter	Symbol	Condition	Rating	Unit	Remark									
Class of environmental test	-	-	55/110/21	-										
Pollution	-	-	2	-										
Maximum operating isolation voltage	U_{IORM} (PEAK)	-	890	V	Refer to the Diagram 1,2 (Attachement-2-3)									
Partial discharge test voltage (Between input and output)														
<table border="1" style="width: 100%;"> <tr> <td style="width: 50%;">Diagram 1</td> <td style="width: 10%;">U_{pr} (PEAK)</td> <td style="width: 20%;">tp=10s, qc<5pC</td> <td style="width: 10%;">1340</td> <td style="width: 10%;">V</td> </tr> <tr> <td>Diagram 2</td> <td></td> <td>tp=1s, qc<5pC</td> <td>1670</td> <td>V</td> </tr> </table>	Diagram 1	U_{pr} (PEAK)	tp=10s, qc<5pC	1340		V	Diagram 2		tp=1s, qc<5pC	1670	V			
Diagram 1	U_{pr} (PEAK)	tp=10s, qc<5pC	1340	V										
Diagram 2		tp=1s, qc<5pC	1670	V										
Maximum over-voltage	U_{IOTM} (PEAK)	t _{INI} =60 s	9000	V										
Safety maximum ratings					Refer to Fig 6,7 (Attachement-2-3)									
1) Case temperature	Tsi	I _F =0, P _C =0,	150	°C										
2) Input current	Isi	P _C =0	200	mA										
3) Electric power (Output or Total power dissipation)	Psi	-	260	mW										
Isolation resistance (Test voltage between input and output ; DC500V)	R_{ISO}	Ta=Tsi	MIN.10 ⁹	Ω										
		Ta=Topr(MAX.)	MIN.10 ¹¹											
		Ta=25°C	MIN.10 ¹²											

6. Precautions in performing isolation test

6.1 Partial discharge test methods shall be the ones according to the specifications of EN 60747-5-2

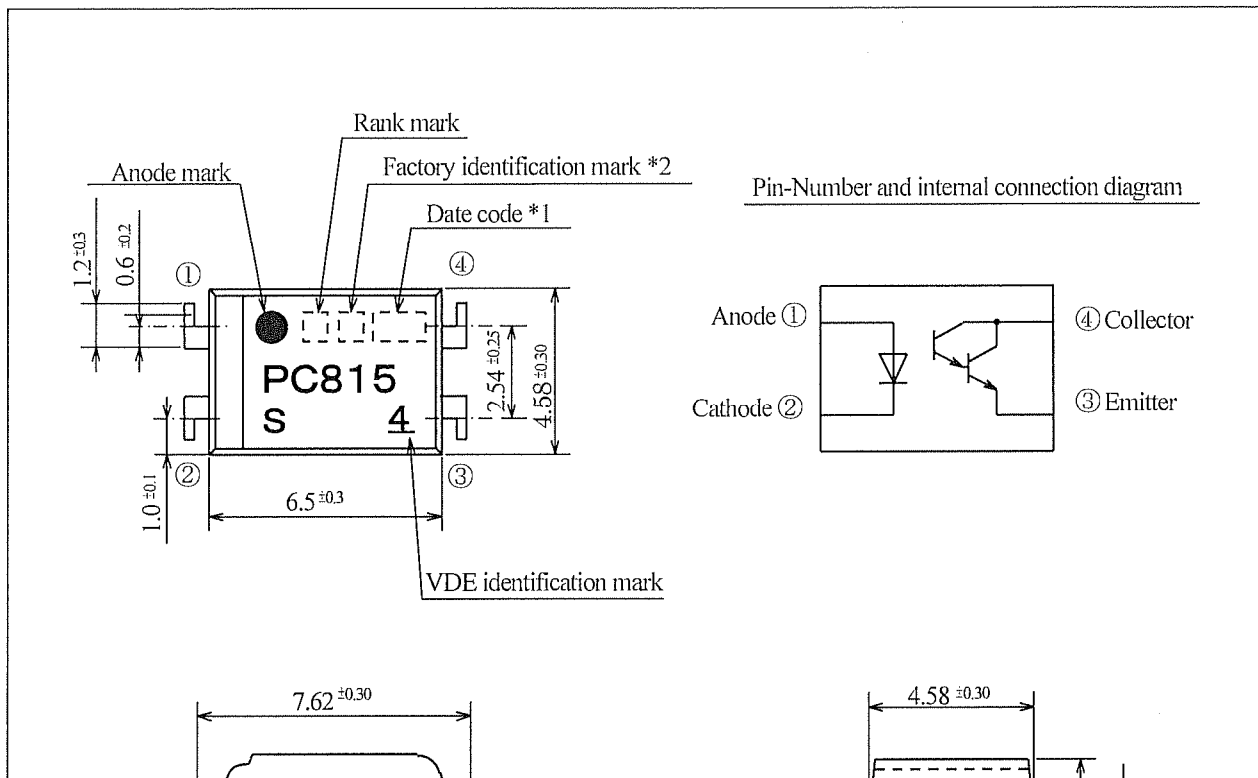
6.2 Please don't carry out isolation test (V_{iso}) over U_{IOTM} . This product deteriorates isolation characteristics by partial discharge due to applying high voltage (ex. U_{IOTM}).

And there is possibility that partial discharge occurs in operating isolation voltage. (U_{IORM}).

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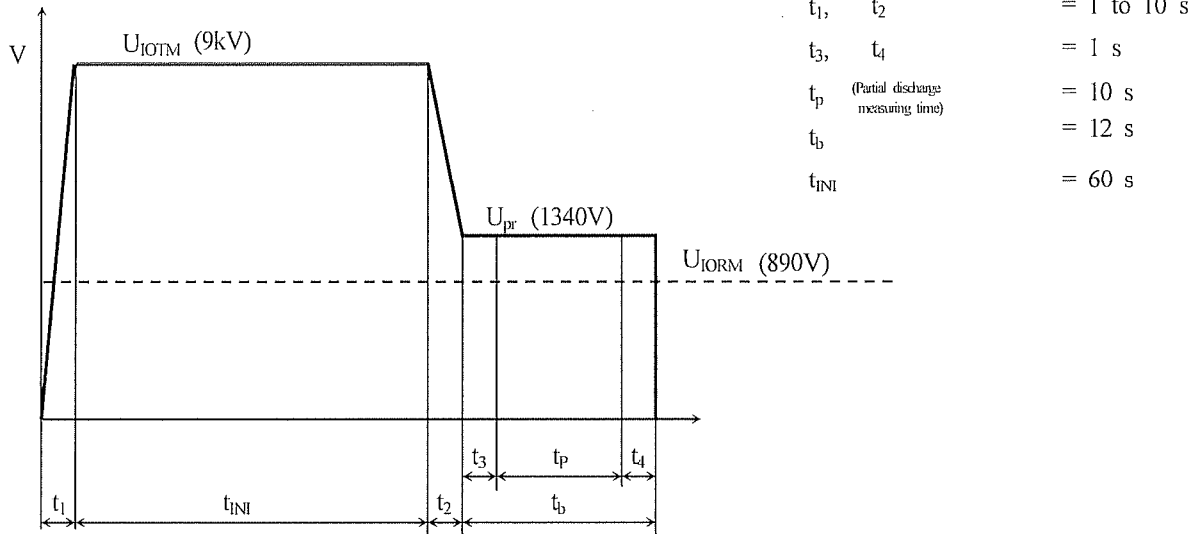
4. Outline



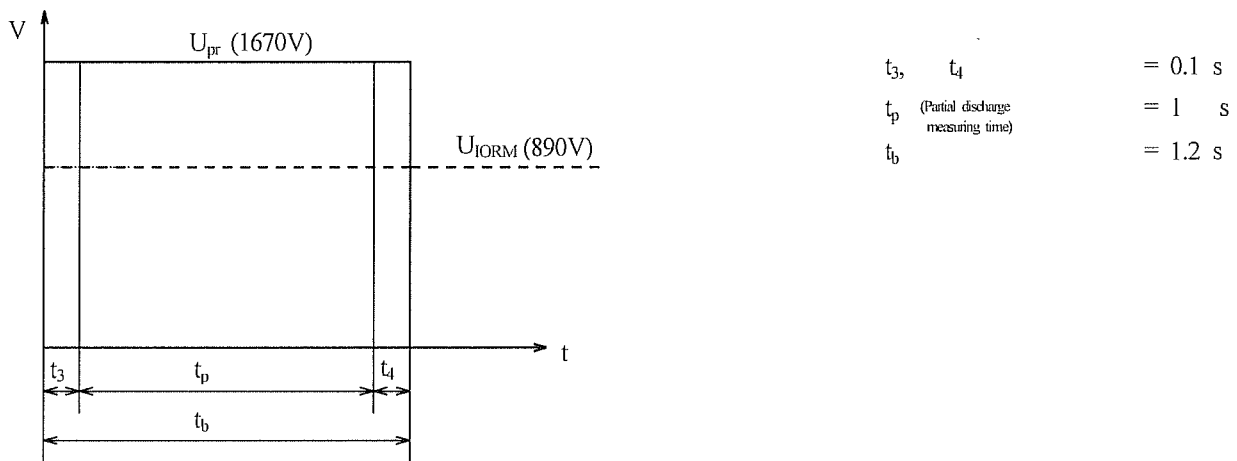
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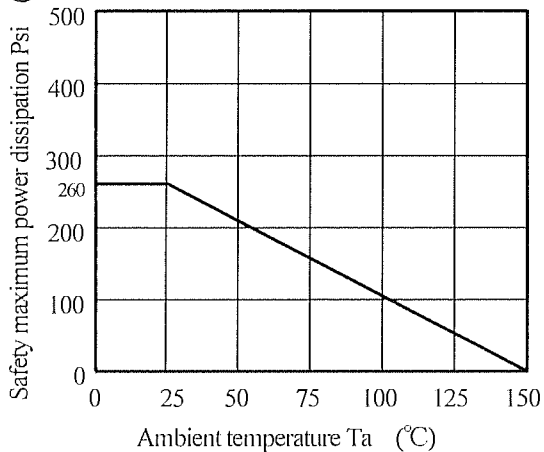
Method of Diagram 1: Breakdown test (Apply to type test and sampling test)



Method of Diagram 2: Non breakdown test (Apply to all device test)



(Fig.6) Safety maximum power dissipation vs. ambient temperature (When failed)



(Fig. 7) Safety maximum forward current vs. ambient temperature (When failed)

